

**Search Notes**

Application/Control No.

10/521,312

Examiner

Joseph P. Martinez

Applicant(s)/Patent under  
Reexamination

TANAKA ET AL.

Art Unit

2873

**SEARCHED**

Class	Subclass	Date	Examiner
359	10, 11, 259, 238	7/26/2006	JPM
345	695, 698	7/26/2006	JPM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
see EAST text search attached: 359/10, 11, 30, 245, 259, 296, 307, 315, 316, 238; 365/125, 216; 345/694, 695, 698;382/210-211	7/26/2006	JPM
see EAST search attached: USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB	7/26/2006	JPM
reviewed PCT X-references	7/26/2006	JPM